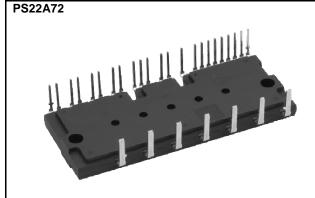
## TRANSFER-MOLD TYPE INSULATED TYPE



## MAIN FUNCTION AND RATINGS

- 3 phase inverter with N-side open emitter structure
- 1200V / 5A (CSTBT)

## APPLICATION

• 0.2~0.4kW / AC400Vrms motor control

## INTEGRATED DRIVE, PROTECTION AND SYSTEM CONTROL FUNCTIONS

- For P-side : Drive circuit, High voltage high-speed level shifting, Control supply under-voltage (UV) protection
- For N-side : Drive circuit, Control supply under-voltage protection (UV), Short circuit protection (SC),
- Fault signaling : Corresponding to SC fault (N-side IGBT), UV fault (N-side supply)
- Temperature monitoring : Analog output of LVIC temperature
- Input interface : 5V line, Schmitt trigger receiver circuit (High Active)
- UL Approved : File No. E80276

### MAXIMUM RATINGS (T<sub>j</sub> = 25°C, unless otherwise noted)

### **INVERTER PART**

Symbol	Parameter	Condition	Ratings	Unit
Vcc	Supply voltage	Applied between P-NU,NV,NW	900	V
V <sub>CC(surge)</sub>	Supply voltage (surge)	Applied between P-NU,NV,NW	1000	V
V <sub>CES</sub>	Collector-emitter voltage		1200	V
±l <sub>C</sub>	Each IGBT collector current	T <sub>c</sub> = 25°C	5	Α
±I <sub>CP</sub>	Each IGBT collector current (peak)	T <sub>c</sub> = 25°C, less than 1ms	10	Α
Pc	Collector dissipation	T <sub>c</sub> = 25°C, per 1 chip	44.6	W
Tj	Junction temperature		-20~+150	°C

#### **CONTROL (PROTECTION) PART**

Symbol	Parameter	Condition	Ratings	Unit
VD	Control supply voltage	Applied between $V_{P1}$ - $V_{PC}$ , $V_{N1}$ - $V_{NC}$	20	V
V <sub>DB</sub>	Control supply voltage	Applied between V <sub>UFB</sub> -V <sub>UFS</sub> , V <sub>VFB</sub> -V <sub>VFS</sub> , V <sub>WFB</sub> -V <sub>WFS</sub>	20	V
V <sub>IN</sub>	Input voltage	Applied between UP, VP, WP-VPC, UN, VN, WN-VNC	-0.5~V <sub>D</sub> +0.5	V
V <sub>FO</sub>	Fault output supply voltage	Applied between Fo-VNC	-0.5~V <sub>D</sub> +0.5	V
I <sub>FO</sub>	Fault output current	Sink current at Fo terminal	1	mA
V <sub>SC</sub>	Current sensing input voltage	Applied between CIN-V <sub>NC</sub>	-0.5~V <sub>D</sub> +0.5	V

#### TOTAL SYSTEM

Symbol	Parameter	Condition	Ratings	Unit
$V_{\text{CC}(\text{PROT})}$	Self protection supply voltage limit (Short circuit protection capability)	$V_D$ = 13.5~16.5V, Inverter Part T <sub>i</sub> = 125°C, non-repetitive, less than 2µs	800	V
T <sub>c</sub>	Module case operation temperature	(Note 1)	-20~+100	°C
T <sub>stg</sub>	Storage temperature		-40~+125	°C
V <sub>iso</sub>	Isolation voltage	60Hz, Sinusoidal, AC 1minute, between connected all pins and heat-sink plate	2500	V <sub>rms</sub>

Note 1: Tc measurement point is described in Fig.1.

## THERMAL RESISTANCE

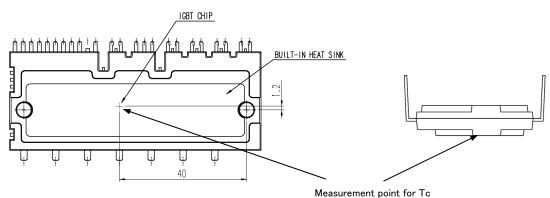
Symbol	Parameter	Condition		Limits		
Symbol Parameter		Condition		Тур.	Max.	Unit
R <sub>th(j-c)Q</sub>	Junction to case thermal	Inverter IGBT part (per 1/6 module)	-	-	2.24	°C/W
R <sub>th(j-c)F</sub>	resistance (Note 2)	Inverter FWDi part (per 1/6 module)	-	-	2.74	°C/W

Note 2: Grease with good thermal conductivity and long-term endurance should be applied evenly with about +100µm~+200µm on the contacting surface of DIPIPM and heat-sink. The contacting thermal resistance between DIPIPM case and heat sink Rth(c-f) is determined by the thickness and the thermal conductivity of the applied grease. For reference, Rth(c-f) is about 0.2°C/W (per 1/6 module, grease thickness: 20µm, thermal conductivity: 1.0W/m•k).



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Fig. 1: T<sub>c</sub> MEASUREMENT POINT



#### **ELECTRICAL CHARACTERISTICS** ( $T_j = 25^{\circ}C$ , unless otherwise noted) **INVERTER PART**

Symbol	ool Parameter Condition			Limits			Unit
Symbol	Falametei	Condition		Min.	Тур.	Max.	Onit
V	Collector-emitter saturation	ollector-emitter saturation $V_D = V_{DB} = 15V$		-	1.9	2.6	V
V <sub>CE(sat)</sub>	voltage	V <sub>IN</sub> = 5V, I <sub>C</sub> = 5A	T <sub>j</sub> = 125°C	-	2.0	2.7	v
V <sub>EC</sub>	FWDi forward voltage	$-I_{C}=5A, V_{IN}=0V$		-	2.2	2.8	V
t <sub>on</sub>				0.5	1.2	1.9	μs
t <sub>C(on)</sub>		V <sub>CC</sub> = 600V, V <sub>D</sub> = V <sub>DB</sub> = 15V		-	0.6	0.9	μs
t <sub>off</sub>	Switching times	Switching times I <sub>C</sub> = 5A, T <sub>j</sub> = 125°C, V <sub>IN</sub> = 0↔5 V Inductive Load (upper-lower arm)		-	2.4	3.5	μs
t <sub>C(off)</sub>				-	0.6	0.9	μs
t <sub>rr</sub>				-	0.5	-	μs
,	Collector-emitter cut-off	V <sub>CF</sub> =V <sub>CFS</sub>	T <sub>j</sub> = 25°C	-	-	1	mA
I <sub>CES</sub>	current	V CE-V CES	T <sub>j</sub> = 125°C	-	-	10	ША

## **CONTROL (PROTECTION) PART**

Symbol	Parameter		Condition			Limits		Unit
Symbol	Falameter		Condition		Min.	Тур.	Max.	
1	Circuit current	Total of V/V/V/V/V/	V <sub>D</sub> = 15	V <sub>D</sub> = 15V, V <sub>IN</sub> = 0V		-	5.60	
I <sub>D</sub>		IULAI UI VP1-VPC, VN1-VN	Total of $V_{P1}-V_{PC}$ , $V_{N1}-V_{NC}$ $V_D = 15V$ ,		-	-	5.60	mA
1	Circuit current	$V_{UFB}$ - $V_{UFS}$ , $V_{VFB}$ - $V_{VFS}$ ,	$V_D = V_D$	<sub>B</sub> = 15V, V <sub>IN</sub> = 0V	-	-	1.10	ШA
I <sub>DB</sub>		$V_{WFB}$ - $V_{WFS}$	$V_D = V_D$	<sub>B</sub> = 15V, V <sub>IN</sub> = 5V	-	-	1.10	
I <sub>SC</sub>	Short circuit trip level	-20°C≤Tj≤125°C, Rs= 261Ω (±1%), Not connecting outer shunt resistors to (Note 3) NU,NV,NW terminals			8.5	-	-	А
UV <sub>DBt</sub>		P-side	D aida	Trip level	10.0	-	12.0	V
$UV_{DBr}$	Control supply under-voltage		r-side	Reset level	10.5	-	12.5	V
$UV_{Dt}$	protection	T <sub>j</sub> ≤125°C	N-side Trip level	Trip level	10.3	-	12.5	V
$UV_{Dr}$			IN-SILLE	Reset level	10.8	-	13.0	V
$V_{\text{FOH}}$	Fault output voltage	$V_{SC}$ = 0V, $F_{O}$ terminal p	ull-up to 5V l	oy 10kΩ	4.9	-	-	V
V <sub>FOL</sub>	Fault output voltage	$V_{SC}$ = 1V, $I_{FO}$ = 1mA			-	-	0.95	V
t <sub>FO</sub>	Fault output pulse width	C <sub>FO</sub> =22nF		(Note 4)	1.6	2.4	-	ms
I <sub>IN</sub>	Input current	V <sub>IN</sub> = 5V			0.7	1.0	1.5	mA
V <sub>th(on)</sub>	ON threshold voltage	Applied between U <sub>P</sub> , V <sub>P</sub> , W <sub>P</sub> -V <sub>PC</sub> , U <sub>N</sub> , V <sub>N</sub> , W <sub>N</sub> -V <sub>NC</sub>			-	-	3.5	V
V <sub>th(off)</sub>	OFF threshold voltage	Applied between Op, V	P, VVP-VPC, U	N, VN, VVN⁻VNC	0.8	-	-	V
V <sub>OT</sub>	Temperature output	LVIC temperature = 85	°C	(Note 5)	3.57	3.63	3.69	V

Note 3 : Short circuit protection can work for N-side IGBTs only. Isc level can change by sense resistance. For details, please refer the application note for this DIPIPM or contact us. And in that case, it should be for sense resistor to be larger resistance than the value mentioned above.

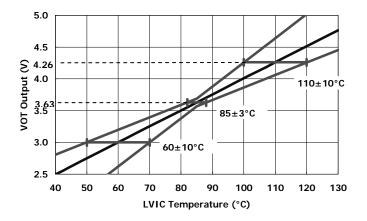
4 : Fault signal is output when short circuit or N-side control supply under-voltage protective functions operate. The fault output pulse-width  $t_{FO}$  depends on the capacitance value of  $C_{FO}$ . ( $C_{FO}$  (typ.) =  $t_{FO} \times (9.1 \times 10^{-6})$  [F])

5 : DIPIPM don't shutdown IGBTs and output fault signal automatically when temperature rises excessively. When temperature exceeds the protective level that user defined, controller (MCU) should stop the DIPIPM. And this output might exceed 5V when temperature rises excessively, so it is recommended for protection of control part like MCU to insert a clamp Di between supply (e.g. 5V) for control part and this output. Temperature of LVIC vs. V<sub>OT</sub> output characteristics is described in Fig.2



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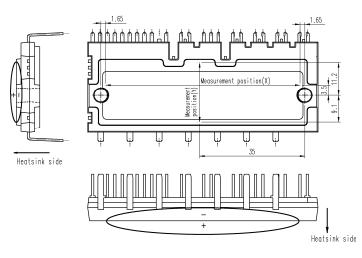
Fig.2 Temperature of LVIC -  $V_{\mbox{\scriptsize OT}}$  output characteristics



## MECHANICAL CHARACTERISTICS AND RATINGS

Parameter	Condition				Unit	
Falainetei	Condition		Min.	Тур.	Max.	Unit
Mounting torque	Mounting screw : M4 Recommended 1.18N·m		0.98	1.18	1.47	N∙m
Terminal pulling strength	Load 19.6N EIAJ- ED-4701		10	-	-	s
Terminal bending strength	Load 9.8N, 90deg. bend EIAJ- ED-4701		2	-	-	times
Weight			-	46	-	g
Heat-sink flatness	(Note 6)		-50	-	100	μm

Note 6: Measurement point of heat-sink flatness





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#### **RECOMMENDED OPERATION CONDITIONS**

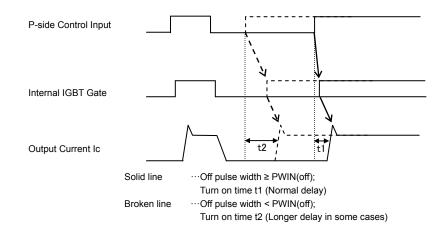
Symbol	Parameter	Parameter Condition			Limits		Unit
Symbol	Falanetei	Condition		Min.	Тур.	Max.	Onic
V <sub>CC</sub>	Supply voltage	Applied between P-NU, NV, NW		350	600	800	V
VD	Control supply voltage	Applied between $V_{P1}$ - $V_{PC}$ , $V_{N1}$ - $V_{NC}$		13.5	15.0	16.5	V
V <sub>DB</sub>	Control supply voltage	Applied between $V_{UFB}$ - $V_{UFS}$ , $V_{VFB}$ - $V_{VFS}$ , $V_{V}$	VFB-VWFS	13.0	15.0	18.5	V
$\Delta V_D, \Delta V_{DB}$	Control supply variation			-1	-	+1	V/µs
t <sub>dead</sub>	Arm shoot-through blocking time	For each input signal, $T_c \le 100^{\circ}C$		3.0	-	-	μs
<b>f</b> <sub>PWM</sub>	PWM input frequency	T <sub>C</sub> ≤ 100°C, T <sub>i</sub> ≤ 125°C		-	-	20	kHz
I <sub>o</sub>	Allowable r.m.s. current	$V_{CC}$ = 600V, $V_{D}$ = 15V, P.F = 0.8, Sinusoidal PWM	f <sub>PWM</sub> = 5kHz	-	-	2.7	Arms
10	Allowable 1.11.5. Guirent	$T_C \le 100^{\circ}C, T_j \le 125^{\circ}C$ (Note 7)	f <sub>PWM</sub> = 15kHz	-	-	1.9	741110
PWIN(on)			(Note 8)	2.0	-	-	
		350≤ V <sub>CC</sub> ≤ 800V, 13.5≤ V <sub>D</sub> ≤ 16.5V,	I <sub>C</sub> ≤5A	2.5	-	-	
PWIN(off)	Minimum input pulse width	$13.0 \le V_{DB} \le 18.5V, -20^{\circ}C \le T_{C} \le 100^{\circ}C,$ N line wiring inductance less than 10nH (Note 9)	5 <i<sub>C≤8.5A</i<sub>	2.9	-	-	μs
V <sub>NC</sub>	V <sub>NC</sub> variation	Between V <sub>NC</sub> -NU, NV, NW (including surg	ge)	-5.0	-	+5.0	V
Tj	Junction temperature			-20	-	125	°C

Note 7: The allowable r.m.s. current value depends on the actual application conditions.

8: DIPIPM might not make response to the input on signal with pulse width less than PWIN (on).

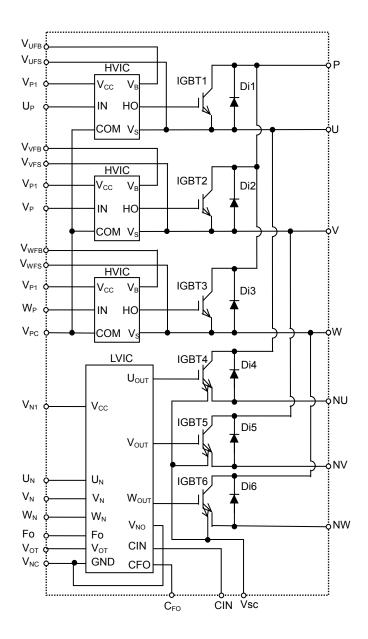
9: IPM might make no response or delayed response (at P-side IGBT only) for the input signal with off pulse width less than PWIN(off). Please refer Fig. 3 about delayed response.

Fig. 3 About Delayed Response Against Shorter Input Off Signal Than PWIN(off) (P-side only)



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## Fig. 4 INTERNAL CIRCUIT





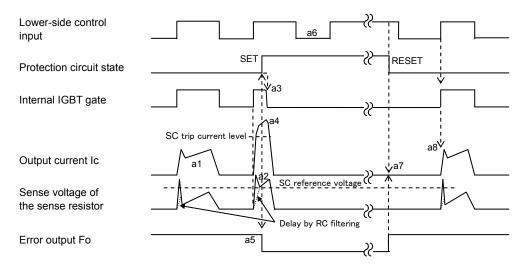
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## Fig. 5 TIMING CHARTS OF THE DIPIPM PROTECTIVE FUNCTIONS

#### [A] Short-Circuit Protection (N-side only with the external sense resistor and RC filter)

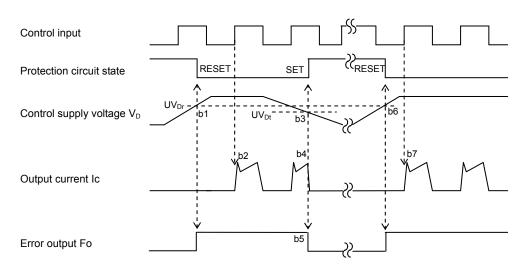
- a1. Normal operation: IGBT ON and outputs current.
- a2. Short circuit current detection (SC trigger) (It is recommended to set RC time constant 1.5~2.0µs so that IGBT shut down within 2.0µs when SC.)
- a3. All N-side IGBT's gates are hard interrupted.
- a4. All N-side IGBTs turn OFF.
- a5.  $F_{\text{O}}$  outputs with a fixed pulse width determined by the external capacitor  $C_{\text{FO}}.$
- a6. Input = "L": IGBT OFF
- a7. Fo finishes output, but IGBTs don't turn on until inputting next ON signal (L $\rightarrow$ H).
- (IGBT of each phase can return to normal state by inputting ON signal to each phase.)

a8. Normal operation: IGBT ON and outputs current.



### [B] Under-Voltage Protection (N-side, UV<sub>D</sub>)

- b1. Control supply voltage V<sub>D</sub> exceeds under voltage reset level (UV<sub>Dr</sub>), but IGBT turns ON when inputting next ON signal (L $\rightarrow$ H). (IGBT of each phase can return to normal state by inputting ON signal to each phase.)
- b2. Normal operation: IGBT ON and outputs current.
- b3. V<sub>D</sub> level drops to under voltage trip level. (UV<sub>Dt</sub>).
- b4. All N-side IGBTs turn OFF in spite of control input condition.
- b5. Fo outputs for the period determined by the capacitance  $C_{FO_i}$  but output is extended during  $V_D$  keeps below  $UV_{Dr}$ .
- b6.  $V_D$  level reaches  $UV_{Dr}$ .
- b7. Normal operation: IGBT ON and outputs current.

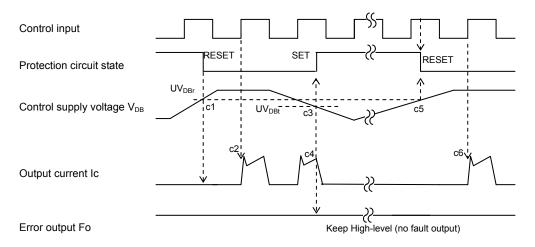




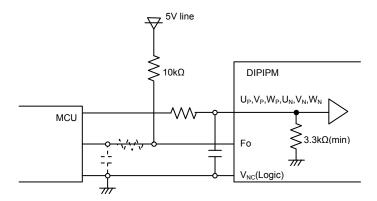
## TRANSFER-MOLD TYPE INSULATED TYPE

## [C] Under-Voltage Protection (P-side, UV<sub>DB</sub>)

- c1. Control supply voltage V<sub>DB</sub> rises. After the voltage reaches under voltage reset level UV<sub>DBr</sub>, IGBT can turn on when inputting next ON signal (L $\rightarrow$ H).
- c2. Normal operation: IGBT ON and outputs current.
- c3.  $V_{DB}$  level drops to under voltage trip level (UV<sub>DBt</sub>).
- c4. IGBT of corresponding phase only turns OFF in spite of control input signal level, but there is no Fo signal output.
- c5.  $V_{DB}$  level reaches  $UV_{DBr}$ .
- c6. Normal operation: IGBT ON and outputs current.



## Fig. 6 MCU I/O INTERFACE CIRCUIT



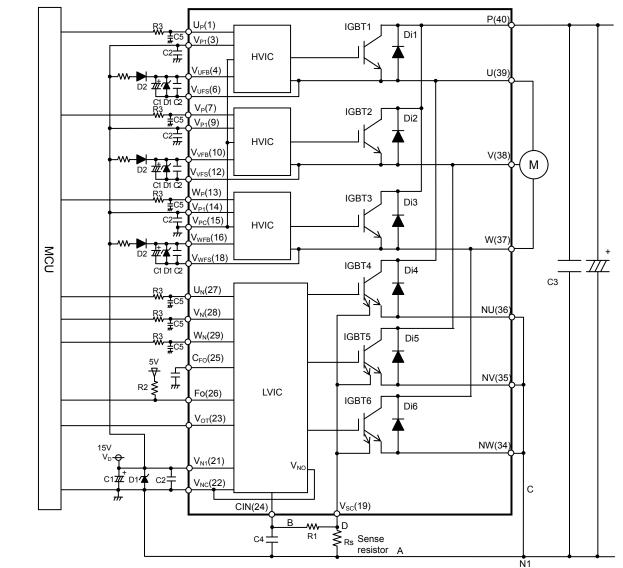
Note)

Design for input RC filter depends on the PWM control scheme used in the application and the wiring impedance of the printed circuit board. But because more noisy in the application for 1200V, it is strongly recommended to insert RC filter. (Time constant: over 100ns. e.g.  $100\Omega$ , 1000pF) The DIPIPM input signal interface integrates a 3.3k $\Omega$ (min) pull-down resistor. Therefore, when using RC filter, be careful to satisfy the turn-on threshold voltage requirement.

Fo output is open drain type. It should be pulled up to the positive side of 5V or 15V power supply with the resistor that limits Fo sink current  $I_{Fo}$  under 1mA. In the case of pulling up to 5V supply, over 5.1k $\Omega$  is needed. (10k $\Omega$  is recommended.)



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#### Note

- 2:To prevent surge destruction, the wiring between the smoothing capacitor and the P,N1 terminals should be as short as possible. Generally inserting a 0.1µ~0.22µF snubber capacitor C3 between the P-N1 terminals is recommended.
- 3 :The time constant R1C4 of RC filter for preventing protection circuit malfunction should be selected in the range of 1.5µs~2µs. SC interrupting time might vary with the wiring pattern. Tight tolerance, temp-compensated type is recommended for R1,C4. When R1 is too small, it will leads to delay of protection. So R1 should be min. 10 times larger resistance than Rs. (Over 100 times is recommended.)
- 4 :All capacitors should be mounted as close to the terminals of the DIPIPM as possible. (C1: good temperature, frequency characteristic electrolytic type, and C2: 0.22μ~2.0μF, good temperature, frequency and DC bias characteristic ceramic type are recommended.)
- 5 : It is recommended to insert a Zener diode D1 (24V/1W) between each pair of control supply terminals to prevent surge destruction.
- 6 :To prevent erroneous SC protection, the wiring from  $V_{SC}$  terminal to CIN filter should be divided at the point D that is close to the terminal of sense resistor. And the wiring should be patterned as short as possible.
- 7 :For sense resistor, the variation within 1% (including temperature characteristics), low inductance type is recommended. And the over 1/8W is recommended, but it is necessary to evaluate in your real system finally.
- 8 :To prevent erroneous operation, the wiring of A, B, C should be as short as possible.

Fig. 7 AN EXAMPLE OF APPLICATION CIRCUIT

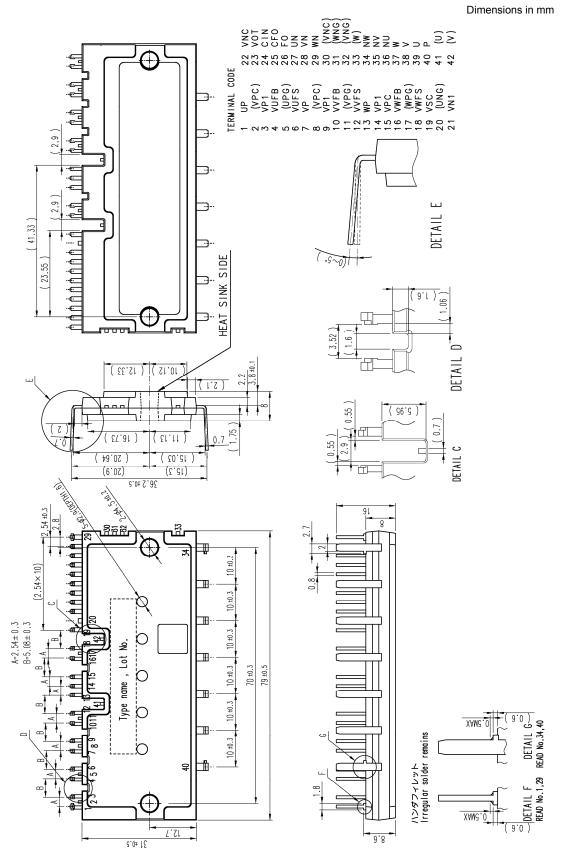
- 9 :Fo output is open drain type. It should be pulled up to the positive side of 5V or 15V power supply with the resistor that limits Fo sink current  $I_{Fo}$  under 1mA. In the case pull up to 5V supply, over R2=5.1k $\Omega$  is needed. (10k $\Omega$  is recommended.)
- 10 :Error signal output width ( $t_{F_0}$ ) can be set by the capacitor connected to  $C_{F_0}$  terminal.  $C_{F_0}(typ.) = t_{F_0} x (9.1 \times 10^{-6}) (F)$
- 11 :High voltage (V<sub>RRM</sub> =1200V or more) and fast recovery type (trr=less than 100ns or less) diode D2 should be used in the bootstrap circuit.
- 12 :If high frequency noise superimposed to the control supply line, IC malfunction might happen and cause erroneous operation. To avoid such problem, voltage ripple of control supply line should meet dV/dt ≤+/-1V/µs, Vripple≤2Vp-p.
- 13 :Input drive is High-Active type. There is a 3.3kΩ(min.) pull-down resistor integrated in the IC input circuit. To prevent malfunction, the wiring of each input should be patterned as short as possible. And it is strongly recommended to insert RC filter (e.g. R3=100Ω and C5=1000pF) and confirm the input signal level to meet the turn-on and turn-off threshold voltage. Thanks to HVIC inside the module, direct coupling to MCU without any opto-coupler or transformer isolation is possible.



<sup>1 :</sup>If control GND is connected to power GND by broad pattern, it may cause malfunction by power GND fluctuation. It is recommended to connect control GND and power GND at only a point at which NU, NV, NW are connected to power GND line.

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#### Fig. 8 PACKAGE OUTLINES





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